

5<sup>th</sup> Generation CoolSiC<sup>™</sup> 1200 V SiC Schottky Diode

## CoolSiC<sup>™</sup> SiC Schottky Diode

#### Features:

- Revolutionary semiconductor material Silicon Carbide
- No reverse recovery current / No forward recovery
- Temperature independent switching behavior
- Low forward voltage even at high operating temperature
- Tight forward voltage distribution
- Excellent thermal performance
- Extended surge current capability
- Specified dv/dt ruggedness
- Qualified according to JEDEC<sup>1)</sup> for target applications
- Pb-free lead plating; RoHS compliant

#### **Benefits**

- System efficiency improvement over Si diodes
- Enabling higher frequency / increased power density solutions
- System size/cost savings due to reduced heatsink requirements and smaller magnetics
- Reduced EMI
- Highest efficiency across the entire load range
- Robust diode operation during surge events
- High reliability
- RelatedLinks: <u>www.infineon.com/sic</u>

#### Applications

- Solar inverters
- Uninterruptable power supplies
- Motor drives
- Power Factor Correction

# Package pin definitions

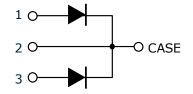
- Pin 1 anode 1
- Pin 2 and backside cathode
- Pin 3 anode 2

#### Key Performance and Package Parameters (leg/device)

Туре	V <sub>DC</sub>	lF	Q <sub>C</sub>	<b>T</b> j,max	Marking	Package
IDW10G120C5B	1200 V	5 / 10 A	28 / 57 nC	175°C	D1012B5	PG-TO247-3

1) J-STD20 and JESD22

Final Data Sheet











5<sup>th</sup> Generation CoolSiC<sup>™</sup> 1200 V SiC Schottky Diode

#### **Table of Contents**

Description	2
Table of Contents	3
Maximum Ratings	4
Thermal Resistances	4
Electrical Characteristics	5
Electrical Characteristics Diagram	5
Package Drawings	9
Revision History	10
Disclaimer	11



5<sup>th</sup> Generation CoolSiC<sup>™</sup> 1200 V SiC Schottky Diode

#### **Maximum ratings**

Parameter	Symbol	Value (leg/device)	Unit	
Repetitive peak reverse voltage	Vrrm	1200	V	
Continuous forward current for $R_{th(j-c,max)}$ $T_c = 156^{\circ}C, D=1$ $T_c = 135^{\circ}C, D=1$ $T_c = 25^{\circ}C, D=1$	IF	5 / 10 8 / 16 17 / 34	A	
Surge non-repetitive forward current, sine halfwave $T_{\rm C}$ =25°C, t <sub>p</sub> =10ms $T_{\rm C}$ =150°C, t <sub>p</sub> =10ms	I <sub>F,SM</sub>	70 / 140 65 / 130	A	
Non-repetitive peak forward current $T_{\rm C} = 25^{\circ}$ C, $t_{\rm 0}$ =10 µs	<i>I</i> <sub>F,max</sub>	530 / 1070	А	
i <sup>2</sup> t value $T_{\rm C} = 25^{\circ}{\rm C}, t_{\rm p} = 10 \text{ ms}$ $T_{\rm C} = 150^{\circ}{\rm C}, t_{\rm p} = 10 \text{ ms}$	∫ i²dt	25 / 98 21 / 84	A²s	
Diode $dv/dt$ ruggedness $V_R=0960 V$	d <i>v</i> /dt	150	V/ns	
Power dissipation for $R_{th(j-c,max)}$ $T_c = 25^{\circ}C$	P <sub>tot</sub>	74 / 148	W	
Operating and storage temperature	Tj;Tstg	-55175	°C	
Soldering temperature, wavesoldering only allowed at leads 1.6mm (0.063 in.) from case for 10 s	T <sub>sold</sub>	260	°C	
Mounting torque M3 and M4 screws	М	0.7	Nm	

#### **Thermal Resistances**

Parameter	Symbol	Conditions	Val	Value (leg/device)		
Falameter	Symbol		min.	typ.	max.	Unit
Characteristic						
Diode thermal resistance, junction – case	R <sub>th(j-c)</sub>		-	1.6/0.8	2.0/1.0	K/W
Thermal resistance, junction – ambient	Rth(j-a)	leaded	-	-	62	K/W



#### **Electrical Characteristics**

#### Static Characteristic, at Tj=25°C, unless otherwise specified

Parameter	Symbol	Conditions	V	Value (leg/device)		
Falamelei	Symbol		min.	typ.	max.	Unit
DC blocking voltage	V <sub>DC</sub>	$T_{\rm j} = 25^{\circ}{\rm C}$	1200	-	-	V
Diada farward valtaga	VF	<i>I</i> ⊧= 5/10 A, <i>T</i> j=25°C	-	1.4	1.65	V
Diode forward voltage	VF	<i>I</i> <sub>F</sub> = 5/10 A, <i>T</i> <sub>j</sub> =150°C	-	1.7	2.30	
Reverse current	4	<i>V</i> <sub>R</sub> =1200 V, <i>T</i> <sub>j</sub> =25°C		3/6	40 / 80	μA
Reverse current	<i>I</i> R	<i>V</i> <sub>R</sub> =1200 V, <i>T</i> <sub>j</sub> =150°C		14 / 28	210 / 420	

#### Dynamic Characteristics, at Tj=25°C, unless otherwise specified

Parameter	Symbol	Conditions	Value (leg/device)			Unit
Faianetei	Symbol		min.	typ.	max.	Sint
Total capacitive charge	Qc	$V_{\rm R} = 800 \text{ V}, \ T_{\rm j} = 150^{\circ} \text{C} \& 25^{\circ} \text{C}$ $Q_{\rm C} = \int_{0}^{V_{\rm R}} C(V) dV$	-	28 / 57	-	nC
Total Capacitance	С	V <sub>R</sub> =1 V, <i>f</i> =1 MHz V <sub>R</sub> =400 V, <i>f</i> =1 MHz V <sub>R</sub> =800 V, <i>f</i> =1 MHz		365 / 730 26 / 51 20 / 41		pF

5



5<sup>th</sup> Generation CoolSiC<sup>™</sup> 1200 V SiC Schottky Diode

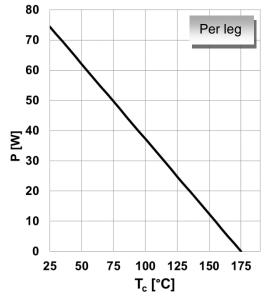


Figure 1. Power dissipation per leg as function of case temperature, P<sub>tot</sub>=f(T<sub>c</sub>), R<sub>th(j-c),max</sub>

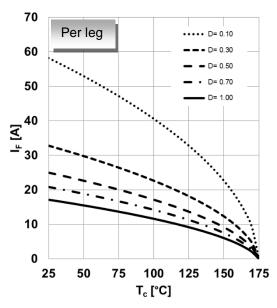


Figure 2. Diode forward current per leg as function of case temperature,  $l_{\text{F}}=f(T_{\text{C}})$ ,  $T_{j}\leq 175^{\circ}\text{C}$ ,  $R_{\text{th}(j\text{-c}),\text{max}}$ , parameter D=duty cycle,  $V_{\text{th}}$ ,  $R_{\text{diff}}$  @  $T_{j}=175^{\circ}\text{C}$ 

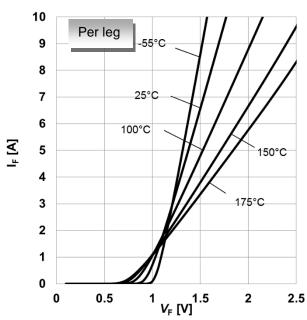


Figure 3. Typical forward characteristics per leg,  $I_F=f(V_F), t_p= 10 \ \mu s, \text{ parameter: } T_j$ 

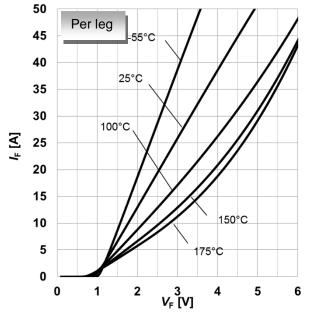


Figure 4. Typical forward characteristics in surge current per leg,  $l_{F}=f(V_{F})$ ,  $t_{p}=10 \ \mu$ s, parameter:  $T_{j}$ 



5<sup>th</sup> Generation CoolSiC<sup>™</sup> 1200 V SiC Schottky Diode

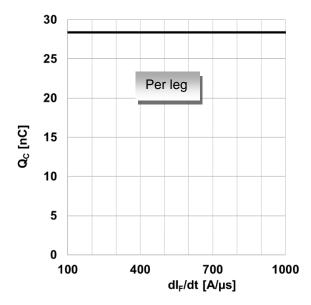


Figure 5. Typical capacitive charge per leg as function of current slope<sup>1</sup>,  $Q_C=f(dI_F/dt)$ ,  $T_j=150^{\circ}C$ 1) guaranteed by design.

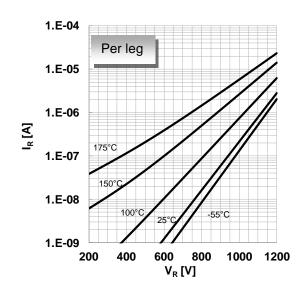
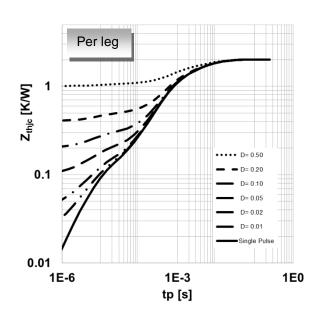
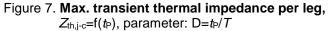


Figure 6. Typical reverse characteristics per leg,  $I_R=f(V_R)$ , parameter:  $T_j$ 





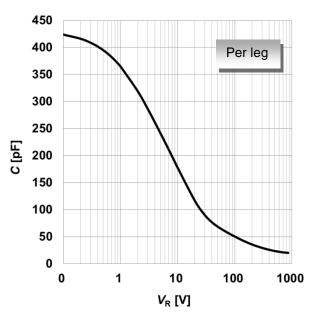


Figure 8. Typical capacitance per leg as function of reverse voltage, C=f(V<sub>R</sub>); T<sub>j</sub>=25°C; f=1 MHz



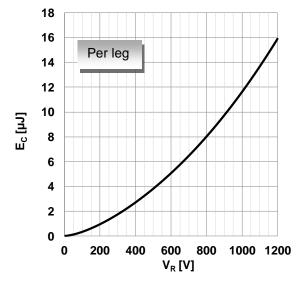


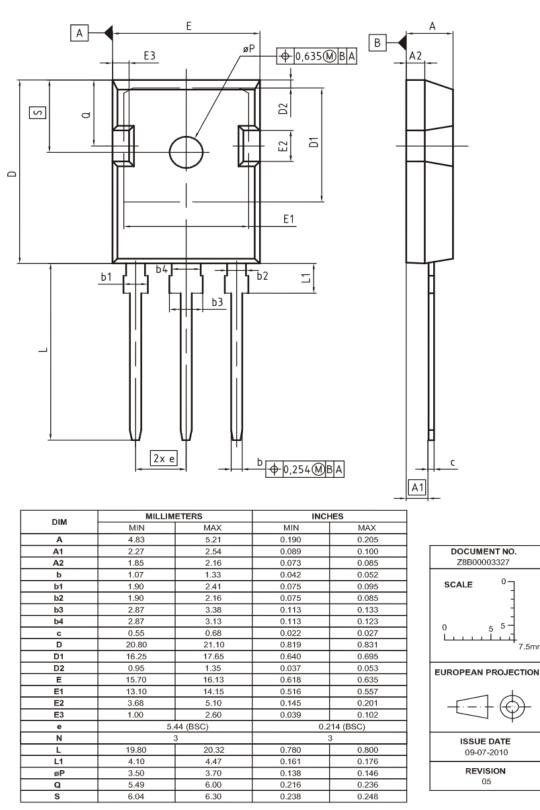
Figure 9. Typical capacitively stored energy as function of reverse voltage, per leg,  $E_{C}=f(V_{R})$ 

**Final Data Sheet** 



#### 5<sup>th</sup> Generation CoolSiC<sup>™</sup> 1200 V SiC Schottky Diode

PG-TO247-3



7.5mn



#### **Revision History**

IDW10G120C5B

#### Revision: 2021-03-01, Rev. 2.2

Previous Revision:						
Revision	Date Subjects (major changes since last version)					
2.0	2014-06-10	Final data sheet				
2.1	2017-07-21	Editorial Changes				
2.2	2021-03-01	Increased dv/dt ruggedness				

#### We Listen to Your Comments

Any information within this document that you feel is wrong, unclear or missing at all? Your feedback will help us to continuously improve the quality of this document. Please send your proposal (including a reference to this document) to: erratum@infineon.com



Published by Infineon Technologies AG 81726 München, Germany © Infineon Technologies AG 2021. All Rights Reserved.

#### **IMPORTANT NOTICE**

The information given in this document shall in <u>no event</u> be regarded as a guarantee of conditions or characteristics ("Beschaffenheitsgarantie"). With respect to any examples, hints or any typical values stated herein and/or any information regarding the application of the product, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation warranties of non-infringement of intellectual property rights of any third party.

In addition, any information given in this document is subject to customer's compliance with its obligations stated in this document and any applicable legal requirements, norms and standards concerning customer's products and any use of the product of Infineon Technologies in customer's applications.

The data contained in this document is exclusively intended for technically trained staff. It is the responsibility of customer's technical departments to evaluate the suitability of the product for the intended application and the completeness of the product information given in this document with respect to such application.

For further information on the product, technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies office (<u>www.infineon.com</u>).

Please note that this product is <u>not</u> qualified according to the AEC Q100 or AEC Q101 documents of the Automotive Electronics Council.

#### **WARNINGS**

Due to technical requirements products may contain dangerous substances. For information on the types in question please contact your nearest Infineon Technologies office.

Except as otherwise explicitly approved by Infineon Technologies in a written document signed by authorized representatives of Infineon Technologies, Infineon Technologies' products may <u>not</u> be used in any applications where a failure of the product or any consequences of the use thereof can reasonably be expected to result in personal injury.

Downloaded from Arrow.com.